

<b>Notice of References Cited</b>	Application/Control No. 10/574,432	Applicant(s)/Patent Under Reexamination SHIGETOMI, TAKASHI	
	Examiner JUSTIN T. DARROW	Art Unit 2438	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	JP 08-143025 A (KUROIWA FUMIO) 1996-05-17 (computer-generated translation into English). [online] [retrieved on 2011-10-03]. Retrieved from: Patent Abstracts of Japan Database.
	V	JP 10-255449 A (ARAI KIYOSHI) 1998-09-25 (computer-generated translation into English). [online] [retrieved on 2011-10-03]. Retrieved from: Patent Abstracts of Japan Database.
	W	JP 2003-187524 A (HIRANO TETSUYUKI et al.) 2003-07-04 (computer-generated translation into English). [online] [retrieved on 2011-10-03]. Retrieved from: Patent Abstracts of Japan Database.
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.